

Notice of References Cited	Application/Control No. 10/790,782	Applicant(s)/Patent Under Reexamination CHO ET AL.	
	Examiner Charles Ehne	Art Unit 2113	Page 1 of 1

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*	B	US-6,400,728	06-2002	Ott, Stefan	370/465
*	C	US-6,654,901	11-2003	Nakai et al.	714/1
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	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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